

Search Notes

Application/Control No.

10/764,001

Examiner

Mark A. Mais

Applicant(s)/Patent under
Reexamination

DUFFIELD ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	229 230 230.1	9/26/2007	MAM
	233 234		
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	237 238		
	241 242		
	244 245		
	250 252		
	253		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See Inventorship Search	9/26/2007	MAM
See Attached Electronic Search	9/26/2007	MAM